Small Signal MOSFET

20 V / -8.0 V, Complementary, +0.63 A / -0.775 A, SC-88

Features

- Complementary N and P Channel Device
- Leading -8.0 V Trench for Low R_{DS(on)} Performance
- ESD Protected Gate ESD Rating: Class 1
- SC-88 Package for Small Footprint (2 x 2 mm)
- Pb-Free Packages are Available

Applications

- DC–DC Conversion
- Load/Power Switching
- Single or Dual Cell Li-Ion Battery Supplied Devices
- Cell Phones, MP3s, Digital Cameras, PDAs

MAXIMUM RATINGS (T_J = 25° C unless otherwise noted)

Paramet	Symbol	Value	Unit			
Drain-to-Source Voltage	N-Ch	V _{DSS}	20	V		
	P-Ch		-8.0			
Gate-to-Source Voltage	Gate-to-Source Voltage			±12	V	
		P-Ch		±8.0		
Continuous Drain Current	N-Ch	$T_A = 25^{\circ}C$	I _D	0.63	А	
– Steady State (Based on R _{θJA})		$T_A = 85^{\circ}C$		0.46		
	P-Ch	$T_A = 25^{\circ}C$		-0.775		
		T _A = 85°C		-0.558		
Continuous Drain Current	N-Ch	T _A = 25°C		0.91		
– Steady State (Based on R _{θJL})		$T_A = 85^{\circ}C$		0.65		
(Dased on hejl)	P-Ch	T _A = 25°C		-1.1		
		T _A = 85°C		-0.8		
Pulsed Drain Current	tp ≤ 10 μs	I _{DM}	±1.2	А		
Power Dissipation - Stead	T _A = 25°C	PD	0.27	W		
(Based on $R_{\theta JA}$)	$T_A = 85^{\circ}C$		0.14			
Power Dissipation - Stead	$T_A = 25^{\circ}C$		0.55			
(Based on $R_{\theta JL}$)	T _A = 85°C		0.29			
Operating Junction and Sto	Т _Ј , Т	–55 to 150	°C			
Course Current (Dodu Diod	NL OF	T _{STG}		^		
Source Current (Body Diod	N-Ch P-Ch	۱ _S	0.63	A		
	-	-0.775				
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C	
THERMAL RESISTANCE RATINGS (Note 1)						
	-	400	0044			

Junction-to-Ambient	Тур	$R_{\theta JA}$	400	°C/W
- Steady State	Max		460	
Junction-to-Lead (Drain)	Тур	$R_{\theta JL}$	194	
- Steady State	Max		226	

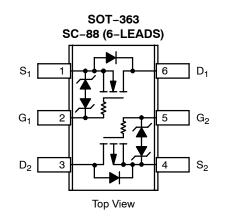
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability. 1. Surface mounted on FR4 board using 1 oz Cu area = 0.9523 in sq.

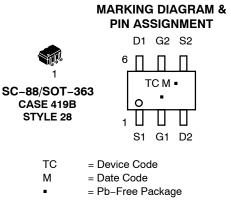


ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} TYP	I _D Max
N-Ch 20 V	0.29 Ω @ 4.5 V	
	0.36 Ω @ 2.5 V	0.63 A
	0.22 Ω @ –4.5 V	
P-Ch -8.0 V	0.32 Ω @ –2.5 V	–0.775 A
	0.51 Ω @ –1.8 V	





(Note: Microdot may be in either location)

ORDERING INFORMATION

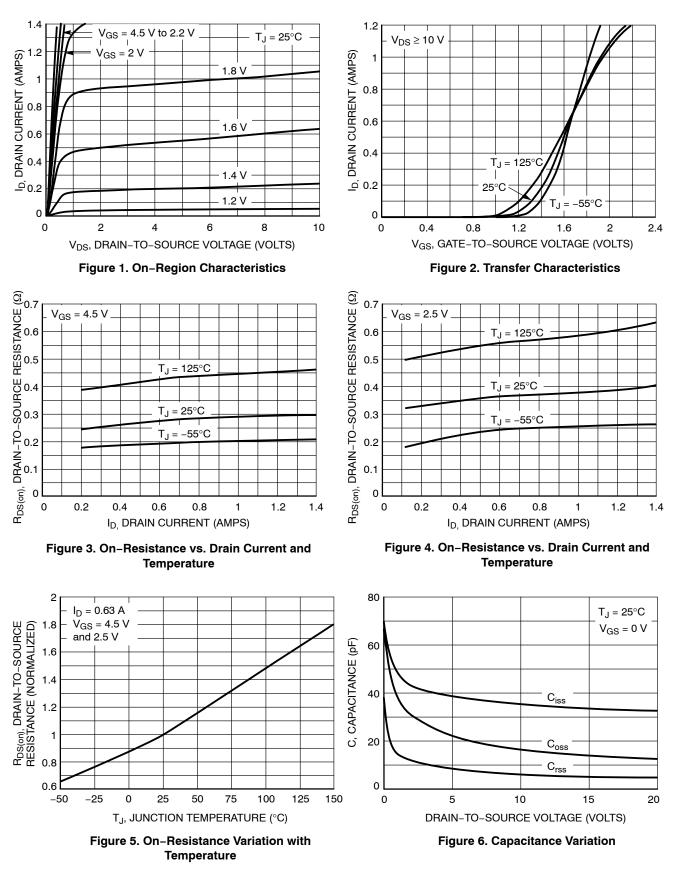
See detailed ordering and shipping information in the package dimensions section on page 7 of this data sheet.

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ELECTRICAL CHARACTERISTICS (T_J = $25^{\circ}C$ unless otherwise noted)

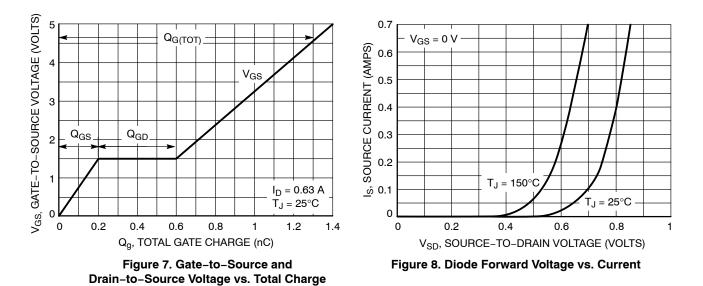
Parameter	Symbol	N/P	Test Conditio	Test Condition		Тур	Max	Units
OFF CHARACTERISTICS								
Drain-to-Source	V _{(BR)DSS}	Ν	V _{GS} = 0 V	I _D = 250 μA	20	27		V
Breakdown Voltage		Р	VGS – O V	I _D = -250 μA	-8.0	-10.5		
Drain-to-Source Breakdown	V _(BR) DSS	Ν				22		mV/ °C
Voltage Temperature Coeffi- cient	/ T _J	Р				-6.0		
Zero Gate Voltage Drain Cur-	I _{DSS}	N	V _{GS} = 0 V, V _{DS} = 16 V				1.0	μΑ
rent	USS	P	$V_{GS} = 0 V, V_{DS} = -6.4 V$	T _J = 25 °C			1.0	μπ
Gate-to-Source	I _{GSS}	Ν		V _{GS} = ±12 V			10	μΑ
Leakage Current		Р	$V_{DS} = 0 V$	V _{GS} = ±8.0			10	
ON CHARACTERISTICS (Note 2	<u>2)</u>							
Gate Threshold Voltage	V _{GS(TH)}	Ν	V _{GS} = V _{DS}	I _D = 250 μA	0.6	0.92	1.5	V
		Р	VGS - VDS	I _D = -250 μA	-0.45	-0.83	-1.0	
Gate Threshold	V _{GS(TH)} /	Ν				-2.1		−mV/ °C
Temperature Coefficient	ТJ	Р				2.2		
Drain-to-Source On Resist-	R _{DS(on)}	Ν	V _{GS} = 4.5 V I _D = 0			0.29	0.375	Ω
ance		Р	V _{GS} = -4.5 V, I _D = -			0.22	0.30	
		Ν	V _{GS} = 2.5 V, I _D = 0			0.36	0.445	1
		Р	V _{GS} = –2.5 V, I _D = -			0.32	0.46	
		Р	V _{GS} = -1.8 V, I _D = -			0.51	0.90	
Forward Transconductance	9 _{FS}	Ν	$V_{DS} = 4.0 \text{ V I}_{D} = 0$			2.0		S
		Р	$V_{DS} = -4.0 \text{ V}, \text{ I}_{D} = -0.57 \text{ A}$			2.0		
CHARGES AND CAPACITANCE	-					1		
Input Capacitance	C _{ISS}	Ν		V _{DS} = 20 V		33	46	pF
	_	Р		V _{DS} = -8.0V		160	225	
Output Capacitance	C _{OSS}	Ν	f = 1 MHz, V _{GS} = 0 V	V _{DS} = 20 V		13	22	
	_	Р	, 40	V _{DS} = -8.0 V		38	55	
Reverse Transfer Capacitance	C _{RSS}	N		$V_{DS} = 20 V$		2.8	5.0	
Total Cata Charge	0	P		$V_{DS} = -8.0 V$		28	40	
Total Gate Charge	Q _{G(TOT)}	N P		V_{GS} = 4.5 V, V_{DS} = 10 V, I_D = 0.7 A V_{GS} = -4.5 V, V_{DS} = -5.0 V, I_D = -0.6 A		1.3 2.2	3.0 4.0	nC
Threshold Gate Charge	0.00	г N	$V_{GS} = -4.5 \text{ V}, V_{DS} = -5.0 \text{ V}_{GS} = 4.5 \text{ V}, V_{DS} = 10 \text{ V}_{SS}$			0.1	4.0	
Theshold Gale Charge	Q _{G(TH)}	P	$V_{GS} = 4.5 \text{ V}, V_{DS} = 10 \text{ V}$ $V_{GS} = -4.5 \text{ V}, V_{DS} = -5.0 \text{ V}$			0.1		
Gate-to-Source Charge	Q _{GS}	N	$V_{GS} = -4.5 \text{ V}, V_{DS} = -5.0 \text{ V}_{GS} = 4.5 \text{ V}, V_{DS} = 10 \text{ V}_{GS}$			0.1		
Gale-10-3001ce Onarge	GGS	P	$V_{GS} = -4.5 \text{ V}, V_{DS} = -5.0 \text{ V}_{GS} = -5.0 \text{ V}_{SS} $			0.2		
Gate-to-Drain Charge	Q _{GD}	N				0.3		
Gate-to-Drain Charge	GD	P	V_{GS} = 4.5 V, V_{DS} = 10 V, I_D = 0.7 A V_{GS} = -4.5 V, V_{DS} = -5.0 V, I_D = -0.6 A			0.4		
SWITCHING CHARACTERISTIC	S (Note 3)		- 45 - 110 V, VDS0.0	., _U = 0.071		0.0		1
Turn-On Delay Time	t _{d(ON)}	Ν				0.083		μs
Rise Time	t _r		V _{GS} = 4.5 V, V _{DD} =	= 10 V.		0.227		
Turn-Off Delay Time	t _{d(OFF)}		$I_{\rm D} = 0.5 \text{ A}, \text{ R}_{\rm G} = 20 \Omega$			0.786		
Fall Time	t _f					0.506		1
Turn-On Delay Time	t _{d(ON)}	Р				0.013		1
Rise Time	t _r		V _{GS} = -4.5 V, V _{DD} =	-4.0 V.		0.023		1
Turn-Off Delay Time	t _{d(OFF)}		$I_{\rm D} = -0.5 \text{ A}, R_{\rm G} = 8.0 \Omega$			0.050		1
Fall Time	t _f					0.036		1
DRAIN-SOURCE DIODE CHAR		cs						•
Forward Diode Voltage	V _{SD}	Ν	N/ 0.1/ T 0700	I _S = 0.23 A		0.76	1.1	V
5		P	V_{GS} = 0 V, T_{J} = 25°C	$I_{\rm S} = -0.23$ A		0.76	1.1	1
		N		I _S = 0.23 A		0.63		1
		P	$V_{GS} = 0 V, T_{J} = 125^{\circ}C$	$I_{\rm S} = -0.23 \rm{A}$		0.63	L	1
				-				
Reverse Recovery Time	t _{RR}	Ν	V _{GS} = 0 V,	I _S = 0.23 A		0.410		μs

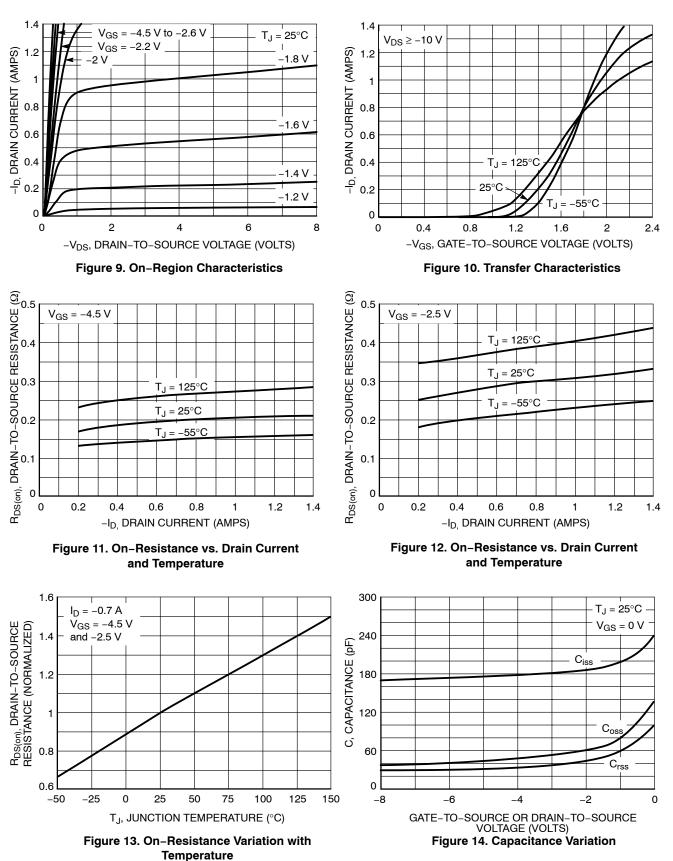
Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.



TYPICAL N-CHANNEL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)

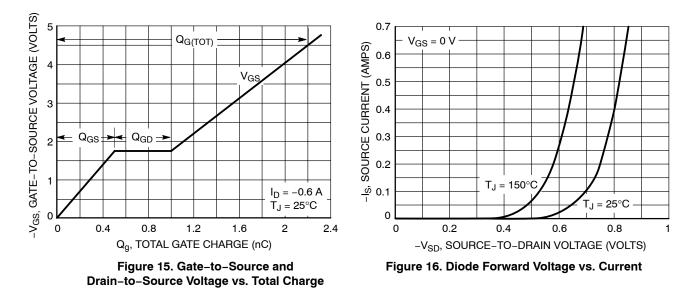
TYPICAL N-CHANNEL PERFORMANCE CURVES (T_J = 25° C unless otherwise noted)





TYPICAL P-CHANNEL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)

TYPICAL P-CHANNEL PERFORMANCE CURVES (T_J = 25° C unless otherwise noted)



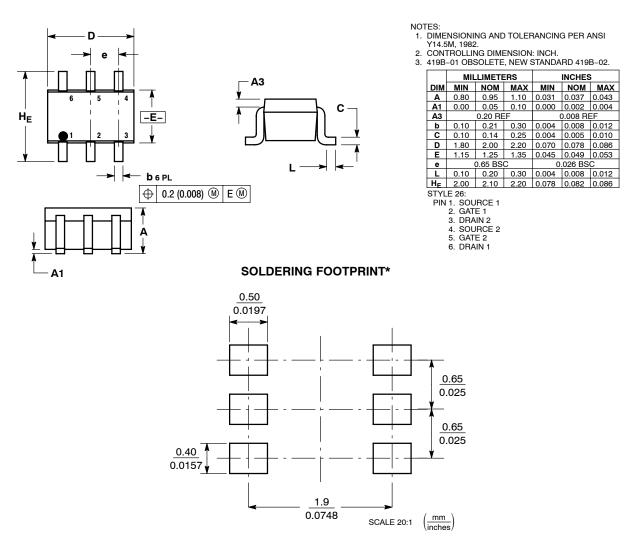
ORDERING INFORMATION

Device	Package	Shipping [†]		
NTJD4105CT1	SOT-363	3000 / Tape & Reel		
NTJD4105CT1G	SOT-363 (Pb-Free)	3000 / Tape & Reel		
NTJD4105CT2	SOT-363	3000 / Tape & Reel		
NTJD4105CT2G	SOT-363 (Pb-Free)	3000 / Tape & Reel		
NTJD4105CT4	SOT-363	10,000 / Tape & Reel		
NTJD4105CT4G	SOT-363 (Pb-Free)	10,000 / Tape & Reel		

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

SC-88/SC70-6/SOT-363 CASE 419B-02 ISSUE W



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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